

Notic o f Reference s Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/039,454	RABADAM ET AL.	
	Examiner	Art Unit	Page 1 of 1
	Thinh T Nguyen	2818	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5273938	12-1993	Lin et al.	437/207
	B	US-5703395	12-1997	Berney	257/681
	C	US-5841190	11-1998	Noda et al.	257/678
	D	US-5949654	09-1999	Fukuoka	361/760
	E	US-6008988	12-1999	Palmer	361/704
	F	US-6274937	08-2001	Ahn et al.	257/777
*	G	US-5596534	01-1997	Manning	365/189.09
*	H	US-6228682	05-2001	Farooq et al.	438/110
*	i	US-6285559	09-2001	Fukiharu	361/760
	J	US-4518982	05-1985	Du bois et al.	357/74
	K	US-4732446	03-1988	Gipson et al.	350/96.15
	L	US-4783697	11-1988	Benenati et al.	357/80
	M	US-5696466	12-1997	Li	330/286

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	US patent Publication US 2002/0079562 by Zhao et al US class 257/678
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.